

Search Notes

Application/Control No.

10/699,676

Examiner

Cuong Q. Nguyen

Applicant(s)/Patent under
Reexamination

YAMADA ET AL.

Art Unit

2811

SEARCHED

Class	Subclass	Date	Examiner
257	347	6-8-05	CL
	506510	11	11

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR